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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/310,256	05/12/1999	SHENG-CHI CHIN	TSMC98-574	8566	
75	590 02/19/2002				
GEORGE O SAILE			EXAMINER		
20 MCINTOSH DRIVE POUGHKEEPSIE, NY 12603			AHMED, S	AHMED, SHAMIM	
			ART UNIT	PAPER NUMBER	
			1746	7	
		DATE MAILED: 02/19/2002			

Please find below and/or attached an Office communication concerning this application or proceeding.

and so	SW -		
	Application No.	Applicant(s)	
Advisory Action	09/310,256	CHIN ET AL.	
navious Addon	Examiner	Art Unit	,,
	Shamim Ahmed	1746	
The MAILING DATE of this communication appe	ars on the cover sheet with the c	orrespondence add	ress
THE REPLY FILED 29 October 2001 FAILS TO PLACE Therefore, further action by the applicant is required to avignal rejection under 37 CFR 1.113 may only be either: (1) condition for allowance; (2) a timely filed Notice of Appea Examination (RCE) in compliance with 37 CFR 1.114.	oid abandonment of this application and indication of the same of	ation. A proper reply n places the applica	y to a ition in
PERIOD FOR RE	PLY [check either a) or b)]		
a) The period for reply expires 3 months from the mailing date	•		
b) The period for reply expires on: (1) the mailing date of this A no event, however, will the statutory period for reply expire I ONLY CHECK THIS BOX WHEN THE FIRST REPLY WAS 706.07(f).	ater than SIX MONTHS from the mailing	d date of the final rejection	on.
Extensions of time may be obtained under 37 CFR 1.136(a). The fee have been filed is the date for purposes of determining the period of fee under 37 CFR 1.17(a) is calculated from: (1) the expiration date of (2) as set forth in (b) above, if checked. Any reply received by the Office timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.136(a). The feet have been filed in the period of the period of the filed in	of extension and the corresponding amo the shortened statutory period for reply the later than three months after the mail	unt of the fee. The approriginally set in the final	opriate extension Office action: or
1. A Notice of Appeal was filed on Appellant's 37 CFR 1.192(a), or any extension thereof (37 CFF			
2. The proposed amendment(s) will not be entered be	ecause:		* 1
(a) they raise new issues that would require further	er consideration and/or search (s	see NOTE below);	
(b) they raise the issue of new matter (see Note b	•		
 (c) they are not deemed to place the application in issues for appeal; and/or 	n better form for appeal by mate	rially reducing or sir	mplifying the
(d) they present additional claims without canceli	ng a corresponding number of fi	nally rejected claim	S.
NOTE: See Continuation Sheet.	in the second se		:
3. Applicant's reply has overcome the following rejecti	on(s):		
4. Newly proposed or amended claim(s) would canceling the non-allowable claim(s).	be allowable if submitted in a se	eparate, timely filed	amendment
5.☐ The a)☐ affidavit, b)☐ exhibit, or c)☐ request for application in condition for allowance because:		dered but does NO	T place the
6. The affidavit or exhibit will NOT be considered becaraised by the Examiner in the final rejection.	ause it is not directed SOLELY to	o issues which were	e newly
7. For purposes of Appeal, the proposed amendment explanation of how the new or amended claims we			and an
The status of the claim(s) is (or will be) as follows:			
Claim(s) allowed:			
Claim(s) objected to:			
Claim(s) rejected: <u>1-22</u> .	•		
Claim(s) withdrawn from consideration:	· · · · · · · · · · · · · · · · · · ·		
8. The proposed drawing correction filed on is	a)☐ approved or b)☐ disapp	roved by the Exami	ner.

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10. Other: ___

9. Note the attached Information Disclosure Statement(s)(PTO-1449) Paper No(s). _____.



Continuation of 2. NOTE: Applicants argue that Blanchard et al differs from the instant application on the ground that Blanchard et al teach a method for reducing foreign matter deposited on a substrate during reactive ion etching, whereas, the instant application disclose a method of reducing dry- etch chamber particle count at the end of power-down for a dry-etch chamber. This is not persuasive because Blanchard et al disclose a process for reducing foreign particles on a substrate to be processed, wherein the power is down to zero in such a manner that particle count is reduced at the end of the power-down process. Blanchard et al, further disclose that the power down procedure starts after the etching process (col.5, lines 54-col.6, lines 2). So, Blanchard et al inherently teach that the particle count is reduced in the dry-etch chamber because the substrate is positioned in the chamber.

Examiner also states that foreign particles will deposit on both the substrate and the dry-etch chamber during RIE process. Since the power-down procedure starts after the etching process. As a result, the foreign particles are reduced on the surface on the substrate and at the same time the dry- etch chamber also have reduced foreign particle count because the substrate is processed on the chamber. Applicants also argue that Blanchard et al do not teach the power-down is performed in a controlled and gradual manner, which is not persuasive because Blanchard et al teach that the reduction of the power is performed in a controlled and gradual manner (col.5, lines 64-col.6, lines 2). Blanchard et al also teach that the particles count reduces at the end of the power-down procedure (col.6, lines 32-40).

In conclusion, examiner states that Blanchard et al disclose a similar process to reduce particle count on the surface of a substrate as well as the dry-etch chamber using a power-down procedure in such a manner that the power or the voltage is gradually reduced to a minimum value, wherein the power-down procedure is a subsequent process of the RIE processing (see claims 1-4).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Shamim Ahmed whose telephone number is (703) 305-1929. The examiner can normally be reached on M-F (7:00-5:30) Every Friday Off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Randy Gulakowski can be reached on (703) 308-4333. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 305-7718 for regular communications and (703) 305-3599 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0661.

Shamim AhmedExaminerArt Unit 1746

SA February 13, 2002

> RANDY GULAKOWSKI SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700